### **DISCRETE SEMICONDUCTORS**

# DATA SHEET

## BTA212X series D, E and F Three quadrant triacs guaranteed commutation

**Product specification** 

June 2003



NXP Semiconductors Product specification

### Three quadrant triacs guaranteed commutation

### BTA212X series D, E and F

### **GENERAL DESCRIPTION**

Passivated guaranteed commutation triacs in a full pack, plastic envelope intended for use in motor control circuits or with other highly inductive loads. These devices balance the requirements of commutation performance and gate sensitivity. The "sensitive gate" E series and "logic level" D series are intended for interfacing with low power drivers, including micro controllers.

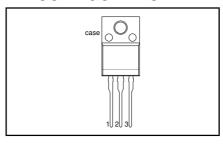
### **QUICK REFERENCE DATA**

SYMBOL	PARAMETER	MAX.	MAX.	UNIT
	BTA212X- BTA212X- BTA212X-	600D 600E 600F	- 800E	
$V_{DRM}$	Repetitive peak off-state	600	800	V
I <sub>T(RMS)</sub> I <sub>TSM</sub>	voltages RMS on-state current Non-repetitive peak on-state current	12 95	12 95	A A

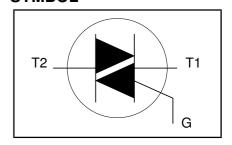
### **PINNING - SOT186A**

PIN	DESCRIPTION			
1	main terminal 1			
2	main terminal 2			
3	gate			
case	isolated			

### PIN CONFIGURATION



### **SYMBOL**



### **LIMITING VALUES**

Limiting values in accordance with the Absolute Maximum System (IEC 134).

SYMBOL	PARAMETER	CONDITIONS	MIN.	MAX.		UNIT
V <sub>DRM</sub>	Repetitive peak off-state voltages		-	<b>-600</b> 600 <sup>1</sup>	<b>-800</b> 800	\ \
I <sub>T(RMS)</sub>	RMS on-state current  Non-repetitive peak on-state current	full sine wave; $T_{hs} \le 56 ^{\circ}C$ full sine wave; $T_i = 25 ^{\circ}C$ prior to	-	12	2	A
l²t dl <sub>⊤</sub> /dt	l <sup>2</sup> t for fusing Repetitive rate of rise of on-state current after	$\begin{array}{l} surge \\ t = 20 \text{ ms} \\ t = 16.7 \text{ ms} \\ t = 10 \text{ ms} \\ l_{TM} = 20 \text{ A}; \ l_G = 0.2 \text{ A}; \\ dl_G/dt = 0.2 \text{ A}/\mu\text{s} \end{array}$	- - -	99 10 45 10	5 5	Α Α Α²s Α/μs
I <sub>GM</sub> P <sub>GM</sub> P <sub>G(AV)</sub>	triggering Peak gate current Peak gate power Average gate power	over any 20 ms period	- - -	2 5 0		A W W
$egin{array}{c} oldsymbol{T}_{stg} \ oldsymbol{T}_{j} \end{array}$	Storage temperature Operating junction temperature	'	-40 -	15 12	-	ပဲ့

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<sup>1</sup> Although not recommended, off-state voltages up to 800V may be applied without damage, but the triac may switch to the on-state. The rate of rise of current should not exceed 15 A/ $\mu$ s.

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### **ISOLATION LIMITING VALUE & CHARACTERISTIC**

 $T_{hs}$  = 25 °C unless otherwise specified

SYMBOL	PARAMETER	CONDITIONS	MIN.	TYP.	MAX.	UNIT
V <sub>isol</sub>	R.M.S. isolation voltage from all three terminals to external heatsink	f = 50-60 Hz; sinusoidal waveform; R.H. ≤ 65%; clean and dustfree	-	-	2500	V
C <sub>isol</sub>	Capacitance from T2 to external heatsink	f = 1 MHz	-	10	-	pF

### THERMAL RESISTANCES

SYMBOL	PARAMETER	CONDITIONS	MIN.	TYP.	MAX.	UNIT
R <sub>th j-hs</sub>	Thermal resistance junction to heatsink	full or half cycle with heatsink compound without heatsink compound			4.0 5.5	K/W K/W
R <sub>th j-a</sub>	Thermal resistance junction to ambient	in free air	-	55	-	K/W

### STATIC CHARACTERISTICS

T<sub>i</sub> = 25 °C unless otherwise stated

SYMBOL	PARAMETER	CONDITIONS	MIN.		MAX.		UNIT
		BTA212X-		D	Е	F	
I <sub>GT</sub>	Gate trigger current <sup>2</sup>	V <sub>D</sub> = 12 V; I <sub>T</sub> = 0.1 A T2+ G+ T2+ G-	-	5 5 5	10 10	25 25	mA mA
   <sub> </sub>	Latching current	T2 - G T2 - G $V_D = 12 \text{ V}; I_{GT} = 0.1 \text{ A}$	-	5	10	25	mA
		T2+ G+ T2+ G- T2- G-	- - -	15 25 25	25 30 30	30 40 40	mA mA mA
I <sub>H</sub>	Holding current	$V_D = 12 \text{ V}; I_{GT} = 0.1 \text{ A}$	-	15	25	30	mA
$egin{array}{c} V_{T} \ V_{GT} \end{array}$	On-state voltage Gate trigger voltage	$I_{T} = 17 \text{ A}$ $V_{D} = 12 \text{ V}; I_{T} = 0.1 \text{ A}$ $V_{D} = 400 \text{ V}; I_{T} = 0.1 \text{ A};$ $T_{i} = 125 \text{ °C}$	- - 0.25		1.6 1.5 -		V V
I <sub>D</sub>	Off-state leakage current	$V_D = V_{DRM(max)}$ ; $T_j = 125  ^{\circ}C$	-		0.5		mA

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<sup>2</sup> Device does not trigger in the T2-, G+ quadrant.

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### **DYNAMIC CHARACTERISTICS**

 $T_j = 25$  °C unless otherwise stated

SYMBOL	PARAMETER	CONDITIONS		MIN.		MAX.	UNIT
		BTA212X-	D	Е	F		
dV <sub>D</sub> /dt	Critical rate of rise of off-state voltage	V <sub>DM</sub> = 67% V <sub>DRM(max)</sub> ; T <sub>j</sub> = 110 °C; exponential waveform; gate open circuit	30	60	70	-	V/μs
dl <sub>com</sub> /dt	Critical rate of change of commutating current	$V_{DM} = 400 \text{ V}; T_j = 125 ^{\circ}\text{C};$ $I_{T(RMS)} = 12 \text{ A};$ $dV_{com}/dt = 10 \text{ V}/\mu\text{s}; \text{ gate}$ open circuit	1.0	8.0	21	-	A/ms
dI <sub>com</sub> /dt	Critical rate of change of commutating current	$ \begin{aligned} &V_{\text{DM}} = 400 \text{ V; } T_{j} = 125 \text{ °C;} \\ &I_{\text{T(RMS)}} = 12 \text{ A;} \\ &dV_{\text{com}}/dt = 0.1 \text{ V/}\mu\text{s; gate} \\ &\text{open circuit} \end{aligned} $	3.5	16	32	1	A/ms

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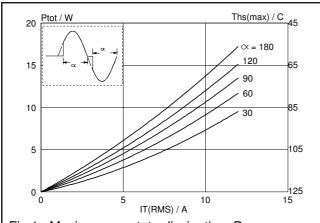


Fig.1. Maximum on-state dissipation,  $P_{tot}$ , versus rms on-state current,  $I_{T(RMS)}$ , where  $\alpha$  = conduction angle.

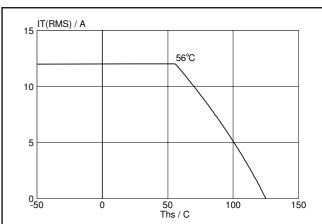


Fig.4. Maximum permissible rms current  $I_{\text{T(RMS)}}$ , versus heatsink temperature  $T_{\text{hs}}$ .

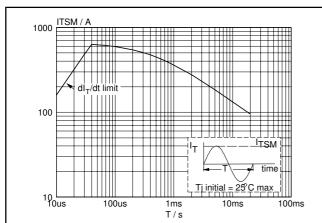


Fig.2. Maximum permissible non-repetitive peak on-state current  $I_{TSM}$ , versus pulse width  $t_p$ , for sinusoidal currents,  $t_p \le 20$ ms.

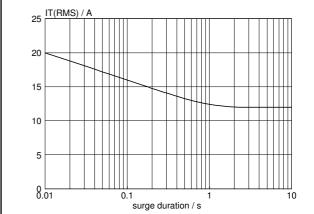


Fig.5. Maximum permissible repetitive rms on-state current  $I_{T(RMS)}$ , versus surge duration, for sinusoidal currents, f = 50 Hz;  $T_{hs} \le 56$ °C.

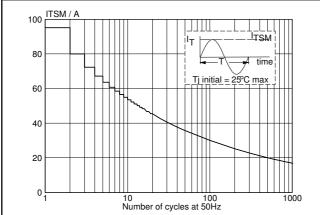


Fig.3. Maximum permissible non-repetitive peak on-state current  $I_{TSM}$ , versus number of cycles, for sinusoidal currents, f = 50 Hz.

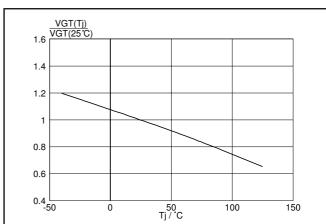
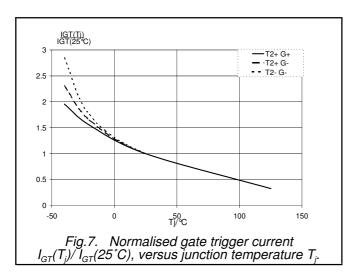
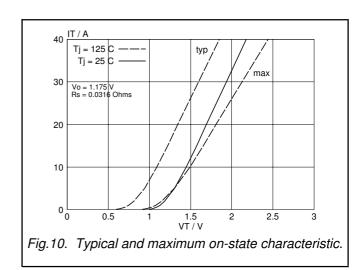


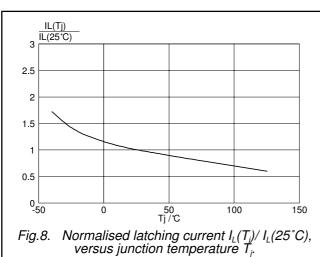
Fig.6. Normalised gate trigger voltage  $V_{GT}(T_i)/V_{GT}(25^{\circ}C)$ , versus junction temperature  $T_i$ .

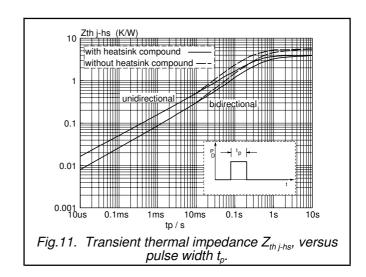
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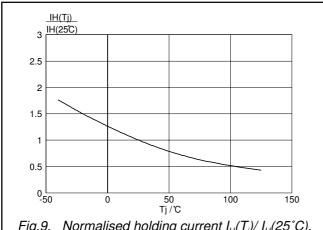
### BTA212X series D, E and F











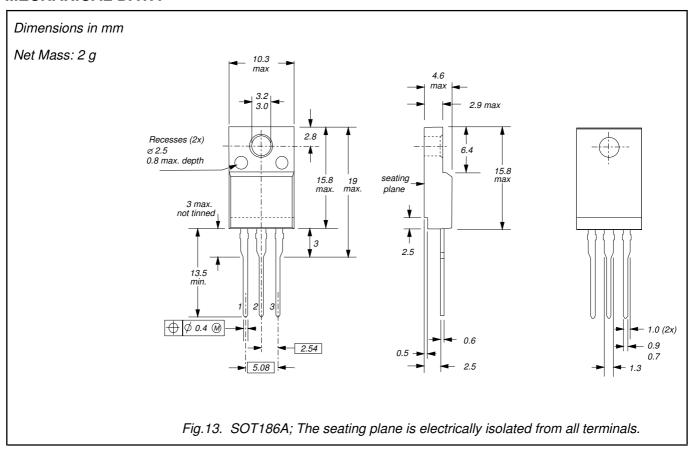
dlcom/dt (A/ms) 10<sup>3</sup> 10<sup>2</sup> 10 1 20 120 Tj (°C) 140 Fig.12. Minimum critical rate of change of

Fig.9. Normalised holding current  $I_H(T_i)/I_H(25^{\circ}C)$ , versus junction temperature  $T_i$ .

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### **MECHANICAL DATA**



- Notes
  1. Refer to mounting instructions for F-pack envelopes.
  2. Epoxy meets UL94 V0 at 1/8".

### Legal information

#### **DATA SHEET STATUS**

DOCUMENT STATUS <sup>(1)</sup>	PRODUCT STATUS <sup>(2)</sup>	DEFINITION
Objective data sheet	Development	This document contains data from the objective specification for product development.
Preliminary data sheet	Qualification	This document contains data from the preliminary specification.
Product data sheet	Production	This document contains the product specification.

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